


<b>Search Notes</b>  	<b>Application/Control No.</b>  10521779	<b>Applicant(s)/Patent Under Reexamination</b>  KOMIYA ET AL.
	<b>Examiner</b>  Thomas, Mia M	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Author/Inventor Search---see attached search history	09/18/07	mmt
382/100, 154,16---image, text and keyword search---see attached search history2	09/19/07	mmt
433/29,167---image, text and keyword search---see attached search history	09/19/07	mmt
D24/152,176---image, text and keyword search---see attached search history	09/19/07	mmt
356 and keyword search---see attached search history	09/19/07	mmt
Electro-Optical Science---Assignee Search---see attached search history	09/19/07	mmt
Consulted W. Chen (AU 2624)	09/25/07	mmt
Consulted B. Werner (AU 2624)	09/26/07	mmt

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner